

<b>Notice of References Cited</b>	Application/Control No. 10/534,153	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Phylesha L. Dabney	Art Unit 2614	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,754,507	06-2004	Takagi, Hisamitsu	455/550.1
*	C	US-7,136,681	11-2006	Sadler et al.	455/575.1
	D	US-			
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	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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	N					
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**NON-PATENT DOCUMENTS**

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